

Notice of References Cited	Application/Control No. <div style="text-align: center;">09/934,817</div>		Applicant(s)/Patent Under Reexam <div style="text-align: center;">Wagner et al</div>	
	Examiner <div style="text-align: center;">Etienne LeRoux</div>		Art Unit <div style="text-align: center;">2858</div>	Page 1 of 1

U.S. PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Name	Classification ²	
A	4,459,016 ✓	6/1984	Tokuhara et al	355	57
B	4,668,077 ✓	5/1987	Tanaka	355	30
C	5,741,056 ✓	4/1998	Liu	353	56
D	3,587,063 ✓	6/1971	Lamberts	340	173
E	5,764,312 ✓	6/1998	Okumura et al	348	785
F	4,595,273 ✓	6/1986	Watanabe et al	355	3R
G	4,855,792 ✓	8/1989	Holbrook et al	355	53
H	4,846,578 ✓	7/1989	Morita et al	356	446
I	6,211,896 ✓	4/2001	Morton	347	225
J	5,557,413 ✓	9/1996	Ebihara et al	358	296
K	4,577,305 ✓	3/1986	Allen et al	369	86
L					
M					

FOREIGN PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Country	Name	Classification ²	
N						
O						
P						
Q						
R						
S						
T						

NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
V	
W	
X	

^{*} A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.